



YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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企业微信二维码



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Product Summary

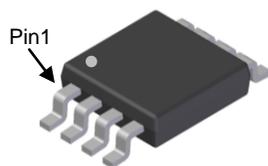
Device	$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D $T_A = +25^\circ C$
Q1	40V	15m Ω @ $V_{GS} = 10V$	12.2A
		20m Ω @ $V_{GS} = 4.5V$	10.6A
Q2	-40V	29m Ω @ $V_{GS} = -10V$	-8.8A
		45m Ω @ $V_{GS} = -4.5V$	-7.1A

Description

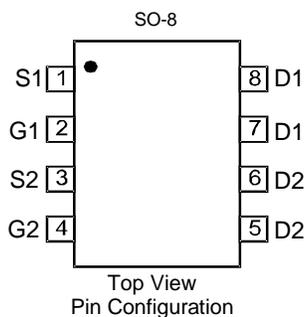
This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) yet maintain superior switching performance, which makes it ideal for high-efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Backlighting



Top View

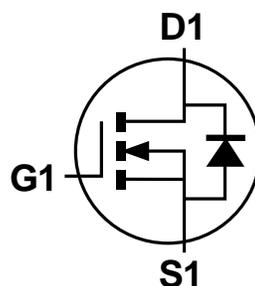


Features and Benefits

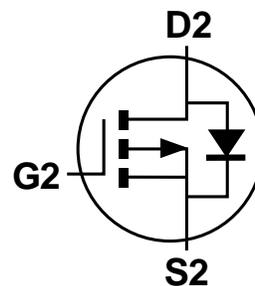
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish—Matte Tin Annealed over Copper Leadframe Solderable per MIL-STD-202, Method 208 
- Weight: 0.074 grams (Approximate)



Q N-Channel MOSFET



Q2 P-Channel MOSFET

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic		Symbol	Value_Q1	Value_Q2	Units
Drain-Source Voltage		V_{DSS}	40	-40	V
Gate-Source Voltage		V_{GSS}	± 20	± 20	V
Continuous Drain Current (Note 6) $V_{GS} = 10\text{V}$	Steady State	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	8.6 6.8	-6.2 -4.9	A
	$t < 10\text{s}$	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	12.2 9.8	-8.8 -7.1	A
Pulsed Drain Current (10 μs Pulse, Duty Cycle = 1%)		I_{DM}	80	-50	A
Maximum Body Diode Forward Current (Note 6)		I_S	2.5	-2.2	A
Pulsed Source Current (10 μs Pulse, Duty Cycle = 1%)		I_{SM}	80	-50	A
Avalanche Current (Note 7) $L = 0.1\text{mH}$		I_{AS}	27	-25	A
Avalanche Energy (Note 7) $L = 0.1\text{mH}$		E_{AS}	37	32	mJ

Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)	$T_A = +25^\circ\text{C}$	P_D	1.2	W
	$T_A = +70^\circ\text{C}$		0.9	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	106	$^\circ\text{C/W}$
	$t < 10\text{s}$		45	
Total Power Dissipation (Note 6)	$T_A = +25^\circ\text{C}$	P_D	1.7	W
	$T_A = +70^\circ\text{C}$		1.1	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	76	$^\circ\text{C/W}$
	$t < 10\text{s}$		37	
Thermal Resistance, Junction to Case (Note 6)		$R_{\theta JC}$	12	$^\circ\text{C/W}$
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Electrical Characteristics N-Channel Q1 (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV_{DSS}	40	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	1	μA	$V_{DS} = 40\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 100	nA	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(th)}$	1	—	3	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(on)}$	—	—	15	m Ω	$V_{GS} = 10\text{V}, I_D = 3\text{A}$
		—	—	20		$V_{GS} = 4.5\text{V}, I_D = 3\text{A}$
Diode Forward Voltage	V_{SD}	—	0.7	1.0	V	$V_{GS} = 0\text{V}, I_S = 1\text{A}$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	—	1810	—	pF	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	—	135	—		
Reverse Transfer Capacitance	C_{rss}	—	112	—		
Gate Resistance	R_G	—	1.7	—	Ω	$V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Total Gate Charge ($V_{GS} = 4.5\text{V}$)	Q_g	—	19	—	nC	$V_{DS} = 20\text{V}, I_D = 3\text{A}$
Total Gate Charge ($V_{GS} = 10\text{V}$)	Q_g	—	40	—		
Gate-Source Charge	Q_{gs}	—	5.5	—		
Gate-Drain Charge	Q_{gd}	—	6.3	—		
Turn-On Delay Time	$t_{D(on)}$	—	5.1	—	nS	$V_{DD} = 20\text{V}, I_D = 3\text{A}$ $V_{GS} = 10\text{V}, R_G = 3\Omega,$
Turn-On Rise Time	t_r	—	5.7	—		
Turn-Off Delay Time	$t_{D(off)}$	—	23	—		
Turn-Off Fall Time	t_f	—	6.3	—		
Body Diode Reverse Recovery Time	t_{rr}	—	12.2	—	nS	$I_S = 3\text{A}, dI/dt = 100\text{A}/\mu\text{s}$
Body Diode Reverse Recovery Charge	Q_{rr}	—	5.4	—	nC	$I_S = 3\text{A}, dI/dt = 100\text{A}/\mu\text{s}$

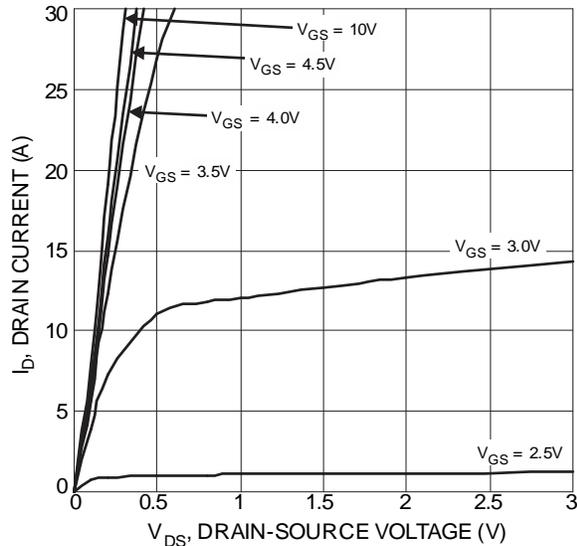


Figure 1 Typical Output Characteristics

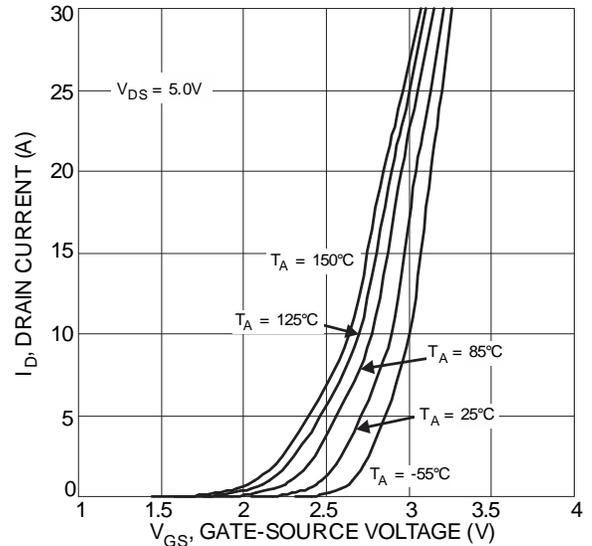


Figure 2 Typical Transfer Characteristics

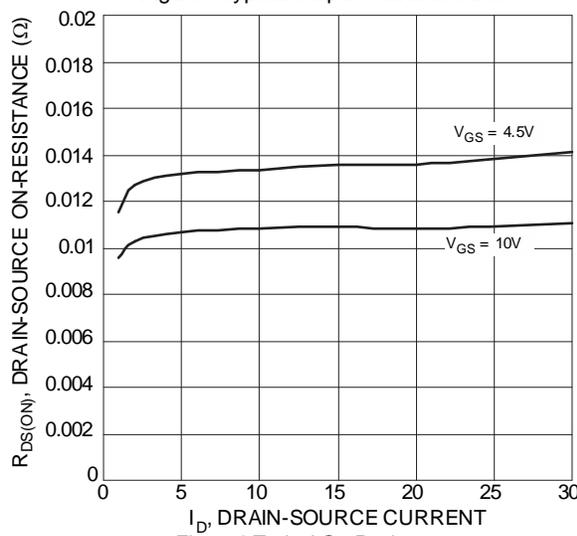


Figure 3 Typical On-Resistance vs. Drain Current and Gate Voltage

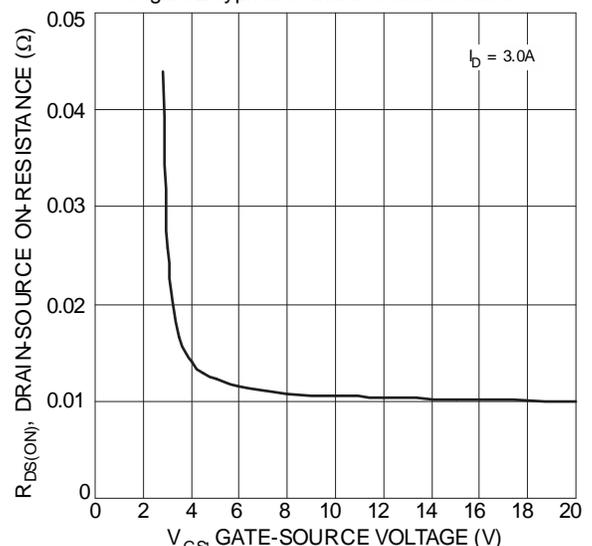


Figure 4 Typical Transfer Characteristic

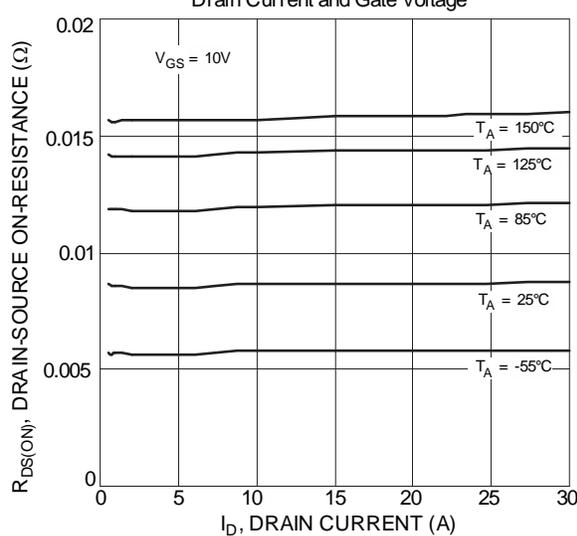


Figure 5 Typical On-Resistance vs. Drain Current and Temperature

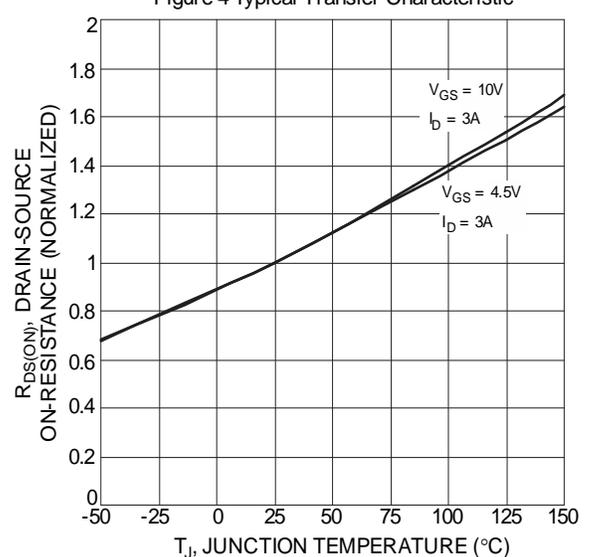


Figure 6 On-Resistance Variation with Temperature

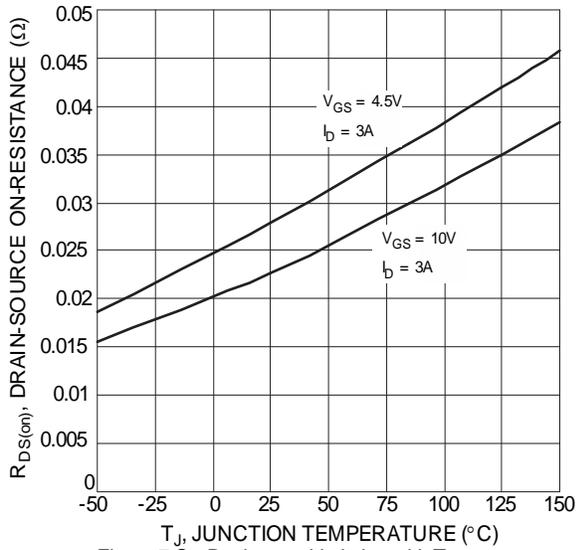


Figure 7 On-Resistance Variation with Temperature

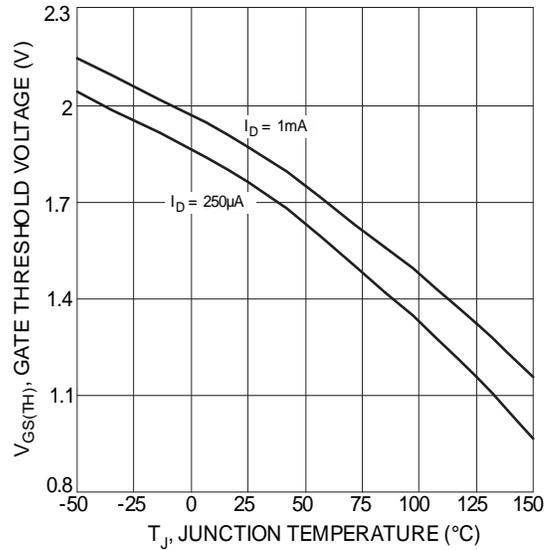


Figure 8 Gate Threshold Variation vs. Ambient Temperature

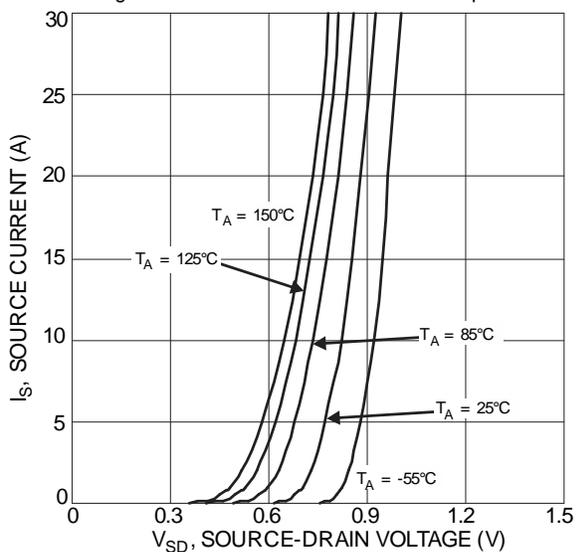


Figure 9 Diode Forward Voltage vs. Current

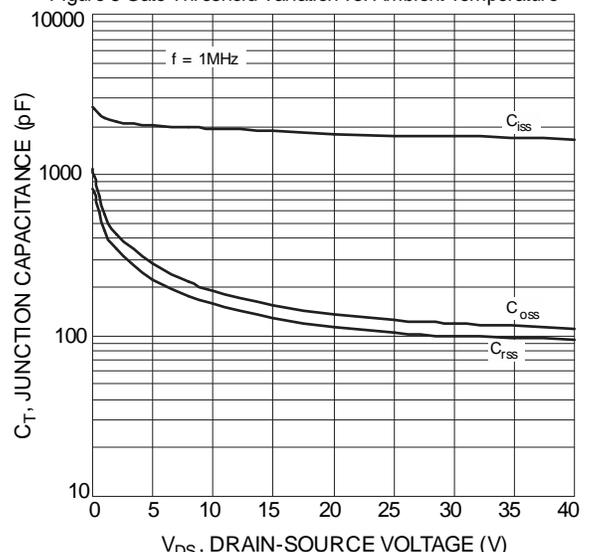


Figure 10 Typical Junction Capacitance

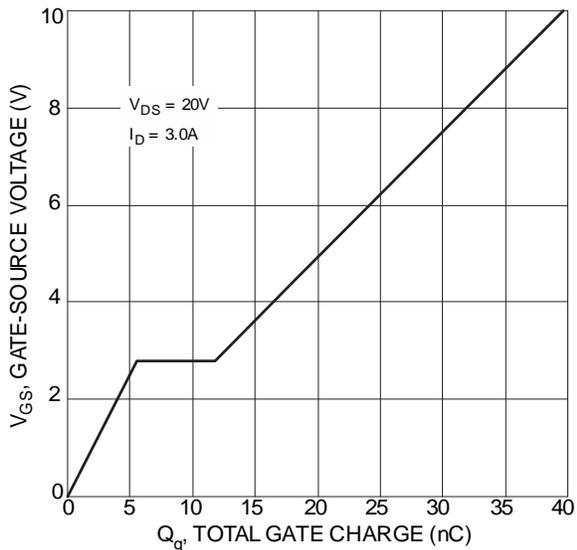


Figure 11 Gate-Charge Characteristics

Electrical Characteristics P-Channel Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	-40	—	—	V	V _{GS} = 0V, I _D = -250μA
Zero Gate Voltage Drain Current	I _{DSS}	—	—	-1	μA	V _{DS} = -40V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	—	—	±100	nA	V _{GS} = ±20V, V _{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	-1	—	-3	V	V _{DS} = V _{GS} , I _D = -250μA
Static Drain-Source On-Resistance	R _{DS(ON)}	—	—	29	mΩ	V _{GS} = -10V, I _D = -3A
		—	—	45		V _{GS} = -4.5V, I _D = -3A
Diode Forward Voltage	V _{SD}	—	-0.7	-1.2	V	V _{GS} = 0V, I _S = -1A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	—	1626	—	pF	V _{DS} = -20V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	C _{oss}	—	135	—		
Reverse Transfer Capacitance	C _{rss}	—	107	—		
Gate Resistance	R _G	—	11	—	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = -4.5V)	Q _g	—	17	—	nC	V _{DS} = -20V, I _D = -3A
Total Gate Charge (V _{GS} = -10V)	Q _g	—	34	—		
Gate-Source Charge	Q _{gs}	—	3.7	—		
Gate-Drain Charge	Q _{gd}	—	6.0	—		
Turn-On Delay Time	t _{D(on)}	—	3.9	—	nS	V _{DD} = -20V, R _L = 1.6Ω V _{GS} = -10V, R _G = 3Ω, I _D = -3A
Turn-On Rise Time	t _r	—	2.8	—		
Turn-Off Delay Time	t _{D(off)}	—	83	—		
Turn-Off Fall Time	t _f	—	30	—		
Body Diode Reverse Recovery Time	t _{rr}	—	17.3	—	nS	I _S = -3A, di/dt = 100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	—	7.2	—	nC	I _S = -3A, di/dt = 100A/μs

- Notes:
5. Device mounted on FR-4 substrate PCB, 2oz copper, with minimum recommended pad layout.
 6. Device mounted on FR-4 substrate PCB, 2oz copper, with 1inch square copper plate.
 7. I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep T_J = +25°C.
 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to product testing.

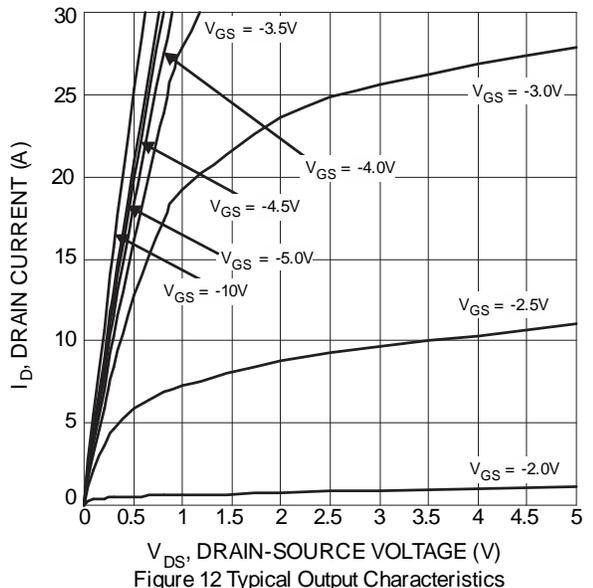


Figure 12 Typical Output Characteristics

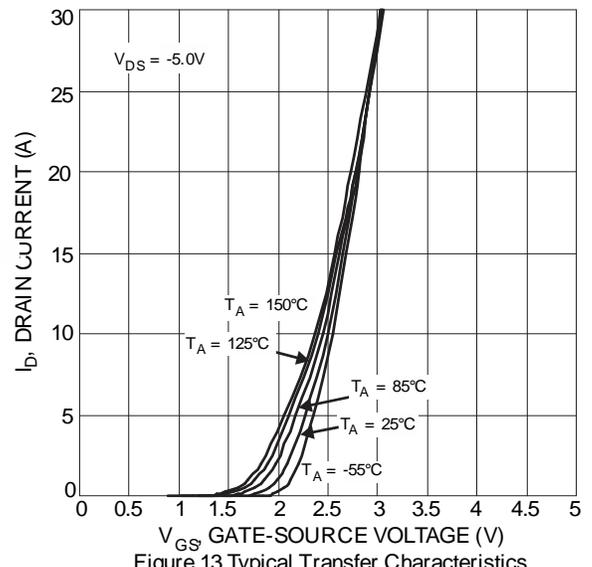


Figure 13 Typical Transfer Characteristics

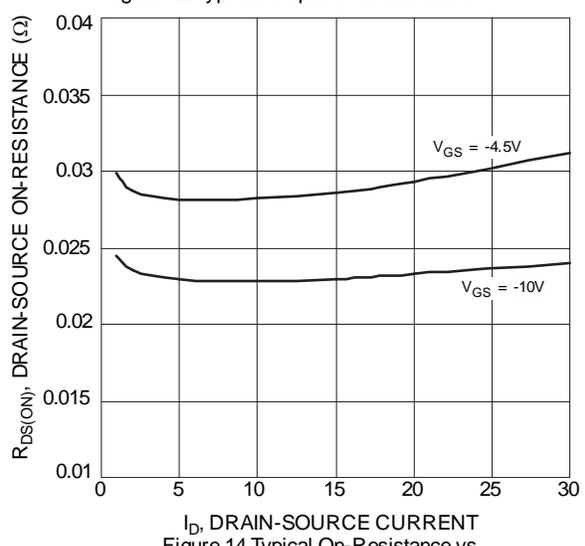


Figure 14 Typical On-Resistance vs. Drain Current and Gate Voltage

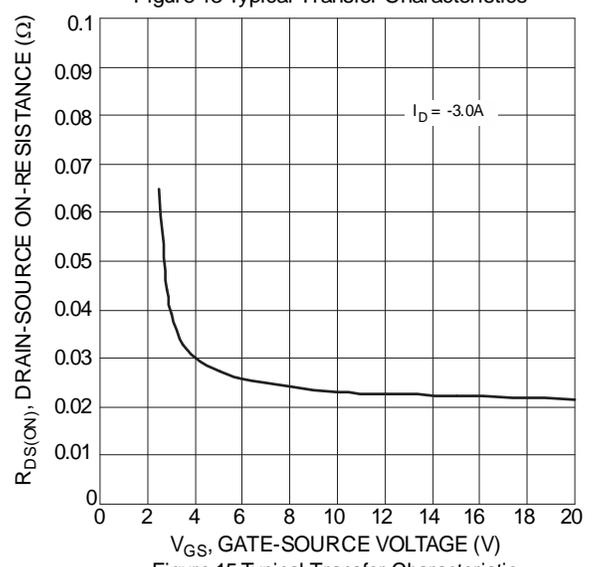


Figure 15 Typical Transfer Characteristic

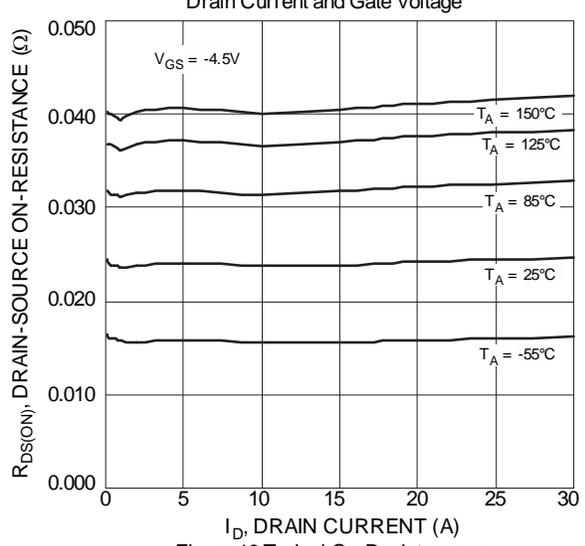


Figure 16 Typical On-Resistance vs. Drain Current and Temperature

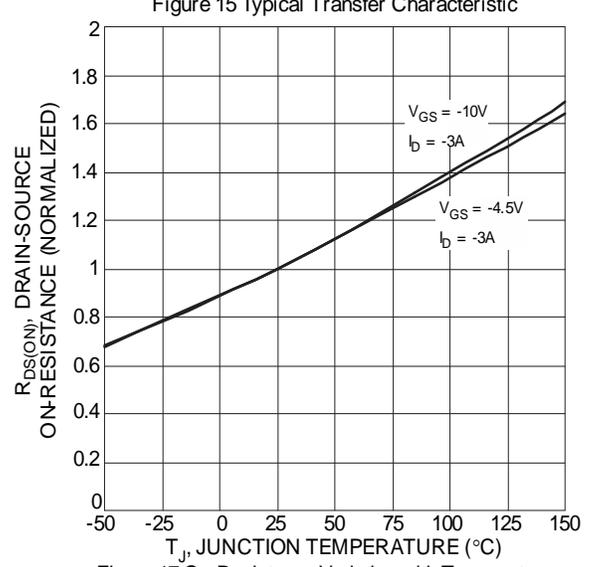


Figure 17 On-Resistance Variation with Temperature

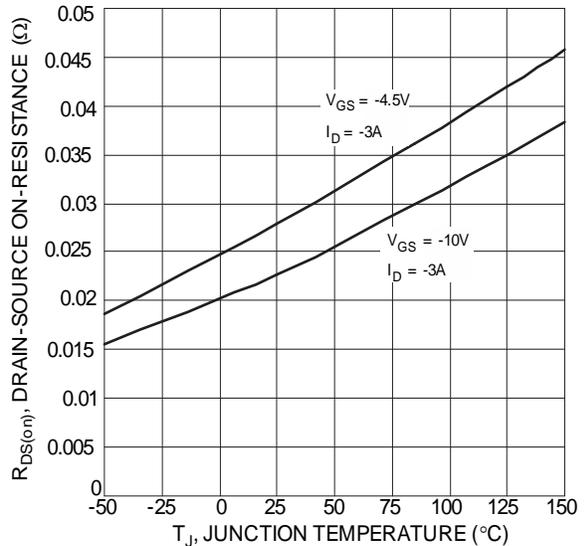


Figure 18 On-Resistance Variation with Temperature

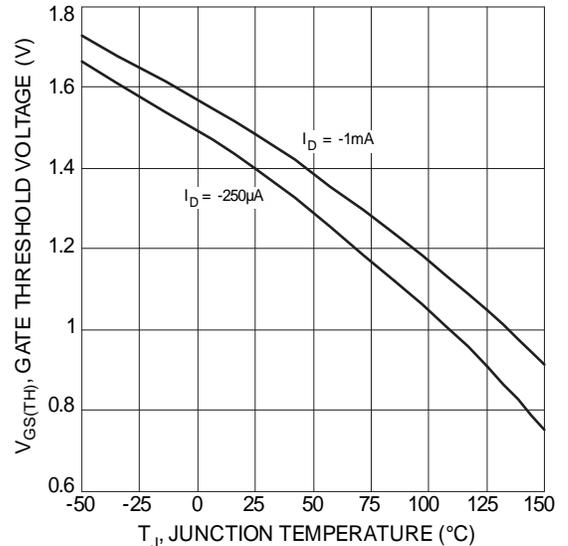


Figure 19 Gate Threshold Variation vs. Ambient Temperature

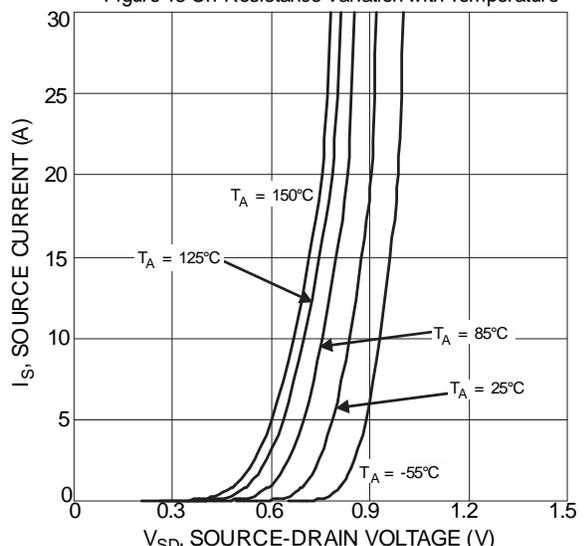


Figure 20 Diode Forward Voltage vs. Current

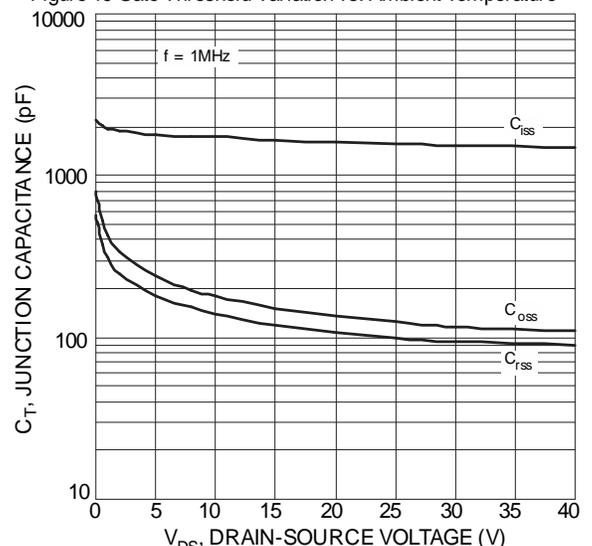


Figure 21 Typical Junction Capacitance

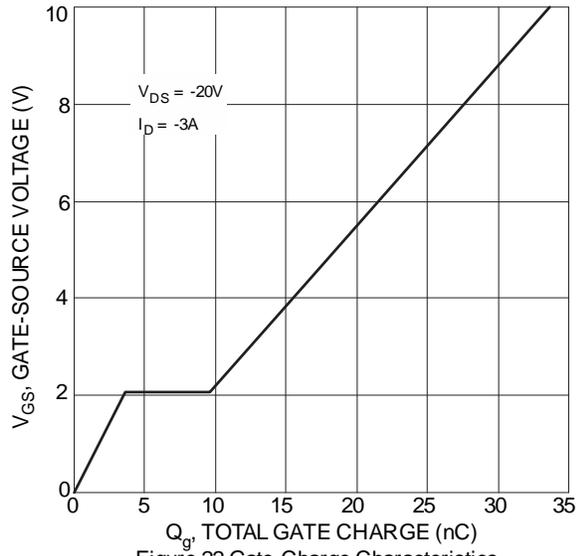
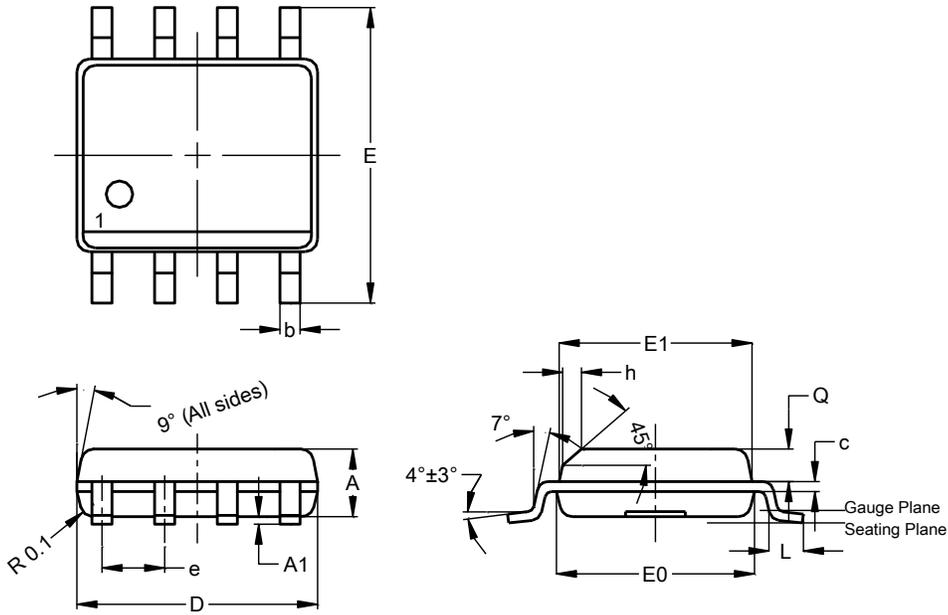


Figure 22 Gate-Charge Characteristics

Package Outline Dimensions

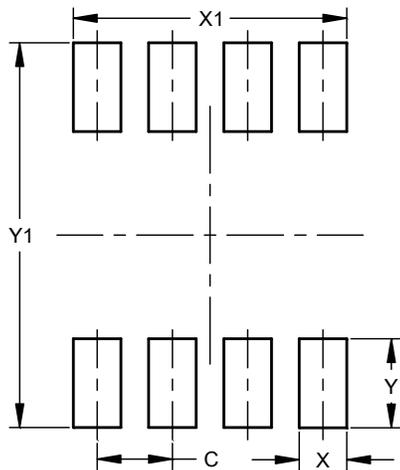
SO-8



SO-8			
Dim	Min	Max	Typ
A	1.40	1.50	1.45
A1	0.10	0.20	0.15
b	0.30	0.50	0.40
c	0.15	0.25	0.20
D	4.85	4.95	4.90
E	5.90	6.10	6.00
E1	3.80	3.90	3.85
E0	3.85	3.95	3.90
e	—	—	1.27
h	—	—	0.35
L	0.62	0.82	0.72
Q	0.60	0.70	0.65
All Dimensions in mm			

Suggested Pad Layout

SO-8



Dimensions	Value (in mm)
C	1.27
X	0.802
X1	4.612
Y	1.505
Y1	6.50